

Search Notes

Application/Control No.

10/615,153

Examiner

Michael Peffley

Applicant(s)/Patent under
Reexamination

OHYAMA ET AL.

Art Unit

3739

SEARCHED

Class	Subclass	Date	Examiner
606	27-31, 41, 42, 45-50	6/14/2005	MP
607	101-105	6/14/2005	MP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR